(Legal Instruments Examiner)	Assistant Examiner)	CLASS SUBCL		712	CLASS		Issue Classification				
7-24 John (Prim	7/21/206 (Date)	SUBCLASS (ONE SUBCLASS PER BLOCK)		209		ORIGINAL					
EDDIE CHAN EDDIE CHAN EDDIE CHAN EXAMINER (Primary EXAMINER) TECHNOLOGY CENTER 2000e)		PER BLOCK)			SUBCLASS			Li, Aimee J	Examiner	09903208	Application/Control No.
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O.G. Print Claim(s) 1	Total Claims Allowed:				NON-CLAIMED	INTERNATIONAL CLASSIFICATION				PETER	Applicant(s)/Patent under Reexamination
O.G. Print Figure 3A	Allowed:				NIMED	Z					tion

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